

Application/Control No.	Applicant(s)/Patent under Reexamination
10/771,770	ELAM ET AL.
Examiner	Art Unit
Nam V. Nguyen	2612

	SEARCHED				
Class	Subclass	Date	Examiner		
340	10.1	9/30/2007	NN		
340	10.2	9/30/2007	NN		
340	573.1	9/30/2007	· NN		
340	572.1	9/30/2007	NN		
340	686.6	9/30/2007	NN		
455	550	9/30/2007	NN		
455	91	9/30/2007	ŇN		
705	22,28,16	9/30/2007	NN		
345	418	9/30/2007	NN .		
235	375	9/30/2007	NN		
235	472.01	9/30/2007	NN		
235	383	9/30/2007	NN		
. 360	55	9/30/2007	NN		

ראו	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Search EAST: USPAT; US-PUB; EPO; JPO; and Derwent.	9/30/2007	NN			
Search Term: RFID reader/interrogator system in enclosure; location/tracking system built-in/plugged-in reader.	.9/30/2007	NN			
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